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OIP SN 10/661,031

PATENTIN THE UNITED STATES PATENT AND TRADEMARK OFFICE*Sent Via Express Mail – Label#: ED 464049585 US*

Applicant: John A. Moon et al. Examiner: Arnel C. Lavarias  
Serial No.: 10/661,031 Group Art Unit: 2872  
Filed: September 12, 2003 Docket: CV-0039A US  
Title: Diffraction Grating-Based Encoded Micro-Particles for Multiplexed Experiments

**SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

In compliance with 37 C.F.R. § 1.56, and in accordance with 37 C.F.R. §§ 1.97 *et. seq.*, the references cited herein are brought to the attention of the Examiner for consideration in connection with the above-identified patent application. Applicants respectfully request that this Supplemental Information Disclosure Statement be entered and the documents listed on the attached Form 1449 be considered by the Examiner and made of record.

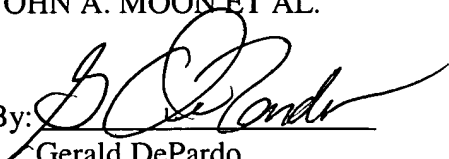
These references are being submitted under 37 C.F.R. § 1.97(b)(4) before the mailing of a first Office action after the filing of a request for continued examination.

Please charge any overpayment or underpayment due to Deposit Account No. 50-2994, Order No. CV-0039A US.

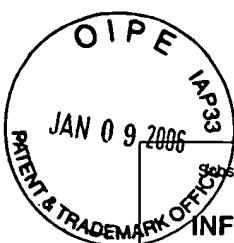
The Examiner is invited to contact the Applicants' Representative at the below-listed telephone number if there are any questions regarding this communication. Pursuant to the current rules, Applicant has not included copies of any US Patents or Published Applications cited with this submission.

Respectfully submitted,

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January 9, 2006



Substitute for form 1449A/PTO

## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

Complete If Known

Application Number	10/661,031
Filing Date	September 12, 2003
First Named Inventor	Moon, John
Art Unit	2872
Examiner Name	A. Lavarias

Sheet

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of

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Attorney Docket No: IP-0015A-US

## US PATENT DOCUMENTS

Examiner Initial *	Cite No	USP Document Number	Publication Date	Name of Patentee or Applicant of cited Document	Filing Date If Appropriate
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Examiner Initials*	Foreign Document No	Publication Date	Name of Patentee or Applicant of cited Document	T <sup>2</sup>
	GB-2129551	05/16/1984	EI, Mochida , et al.	
	IB-WO 01/58583 A1	08/16/2001	Maiefski,	
	WO-0016893A2	03/30/2000	Dames, A. , et al.	
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	WO-03/061983	07/31/2003	Steenblik, Richard A.	

EXAMINER

DATE CONSIDERED

Substitute Disclosure Statement Form (PTO-1449)

\* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. 1 Applicant's unique citation designation number (optional) 2 Applicant is to place a check mark here if English language Translation is attached

Substitute for form 1449A/PTO  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>   (Use as many sheets as necessary)				<i>Complete if Known</i>	
				<b>Application Number</b>	10/661,031
				<b>Filing Date</b>	September 12, 2003
				<b>First Named Inventor</b>	Moon, John
				<b>Art Unit</b>	2872
				<b>Examiner Name</b>	A. Lavarias
Sheet	2	of	2	Attorney Docket No: IP-0015A-US	

OTHER DOCUMENTS -- NON PATENT LITERATURE DOCUMENTS				
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>	
		NICEWARNER-PENA, S. R., et al., "Submicrometer Metallic Barcodes", <u>Science</u> , American Association for the Advancement of Science, 294(5540), ISSN: 0036-8075, www.sciencemag.org, (Oct. 05, 2001), 137-141		
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EXAMINER

DATE CONSIDERED